

<b>Notice of References Cited</b>	Application/Control No. 10/589,511		Applicant(s)/Patent Under Reexamination OZAKI ET AL.	
	Examiner Duy-Vu N. Deo		Art Unit 1713	Page 1 of 1

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*	B	US-6,872,323	03-2005	Entley et al.	216/67
*	C	US-6,914,927	07-2005	Watson et al.	372/58
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	M	US-			

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**NON-PATENT DOCUMENTS**

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